MOSFET – Power, Dual N-Channel 60 V, 44 mΩ, 20 A

Features

- Small Footprint (5x6 mm) for Compact Designs
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- 175°C Operating Temperature
- NVMFD5485NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- This is a Pb-Free Device

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	60	V
Gate-to-Source Voltage)		V _{GS}	±20	V
Continuous Drain		T _C = 25°C	ſD	19.5	Α
Current R _{0JC} (Notes 1, 2, 4)	Steady	T _C = 100°C		13.8	NE
Power Dissipation	State	T _C = 25°C	PD	38.5	W
R _{θJC} (Notes 1, 2)		T _C = 100°C		19.2	C,
Continuous Drain		$T_A = 25^{\circ}C$	B	5.3	Α
Current R _{θJA} (Notes 1, 3 & 4)	Steady	T _A = 100°C	, , C.	3.8	E,
Power Dissipation	State	T _A = 25°C	P_{D}	2.9	W
R _{θJA} (Notes 1 & 3)		T _A = 100°C	0/1/	1.4	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 µs	CIDM	113	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to 175	°C
Source Current (Body Diode)			I _S	37	Α
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, V _{DD} = 50 V, V _{GS} = 10 V, $I_{L(pk)}$ = 25 A, L = 0.1 mH, I_{RG} = 25 $I_{L(pk)}$			E _{AS}	31	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

	`	,	
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{\theta JC}$	3.9	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	52	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted to an ideal (infinite) heat sink.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 4. Maximum current for pulses as long as 1 second are higher but are dependent on pulse duration and duty cycle.

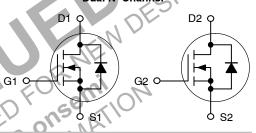


ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
60 V	44 mΩ @ 10 V	20 A	
	60 mΩ @ 4.5 V	2014	

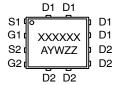
Dual N-Channel



1

MARKING DIAGRAM

DFN8 5x6 (SO8FL) CASE 506BT



XXXXXX = 5485NL

(NVMFD5485NL) or

5485LW

(NVMFD5485NLWF)

A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

ONDENING INFORMATION					
Device	Package	Shipping [†]			
NVMFD5485NLT1G	DFN8 (Pb-Free)	1500/ Tape & Reel			
NVMFD5485NLT3G	DFN8 (Pb-Free)	5000/ Tape & Reel			
NVMFD5485NLWFT1G	DFN8 (Pb-Free)	1500/ Tape & Reel			
NVMFD5485NLWFT3G	DFN8 (Pb-Free)	5000/ Tape & Reel			

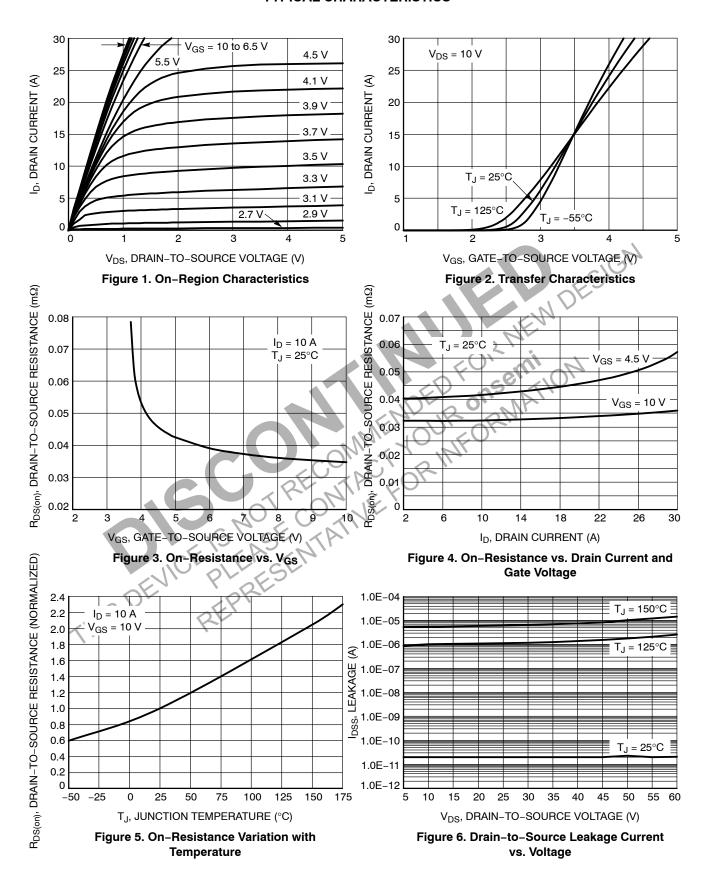
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 2	250 μA	60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	Reference to 2 I _D = 250 μΑ			67		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ
		$V_{DS} = 60 \text{ V}$	T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS} =$: ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2$	250 μΑ	1.5		2.5	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J	Reference to 2 I _D = 250 μA			-4.86		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D =	= 15 A		33	44	mΩ
		V _{GS} = 4.5 V, I _D =	= 10 A		42	60	1
CHARGES AND CAPACITANCES						CIO.	
Input Capacitance	C _{iss}				560)	pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MHz	, V _{DS} = 25 V		126		Ī
Reverse Transfer Capacitance	C _{rss}			16	58		1
Total Gate Charge	Q _{G(TOT)}			2	20		nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 10 \text{ V. } V_{DS} = 10 \text{ V. } V_{D$	= 48 V.	D' .«	0.52		1
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 10 \text{ V}, V_{DS} = I_D = 10 \text{ A}$	OY	681	1.9		1
Gate-to-Drain Charge	Q_{GD}		OF C	11, 10	7.9		1
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 4.5 \text{ V}, V_{DS}$ $I_{D} = 10 \text{ A}$	= 48 V,	DEM	11.5		nC
SWITCHING CHARACTERISTICS (N	ote 6)	ONLINE	10,71				
Turn-On Delay Time	t _{d(on)}	(C),(C)	211		9.5		ns
Rise Time	tr	$V_{GS} = 4.5 \text{ V, } V_{DS}$	= 48 V,		26.6		1
Turn-Off Delay Time	t _{d(off)}	$I_D = 10 \text{ A, R}_G =$	2.5 Ω		27.8		1
Fall Time	No 1	0,41/1			23.7		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS	YY,					
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	T _J = 25°C		0.93	1.2	V
	1/2/5	I _S = 15 A	T _J = 125°C		0.83		1
Reverse Recovery Time	t _{RR}		I		28.9		ns
Charge Time	t _a	$V_{GS} = 0 \text{ V}, d_{IS}/d_t = 0$	100 A/μs,		23.2		1
Discharge Time	t _b	I _S = 10 A			5.6		
Reverse Recovery Charge	Q _{RR}				35.5		nC
PACKAGE PARASITIC VALUES				•	•		
Source Inductance	L _S				0.93		nH
Drain Inductance	L _D	T _A = 25°C			0.005		1
Gate Inductance	L _G				1.84		1
Gate Resistance	R_{G}				12		Ω

^{5.} Pulse Test: pulse width = 300 μ s, duty cycle \leq 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

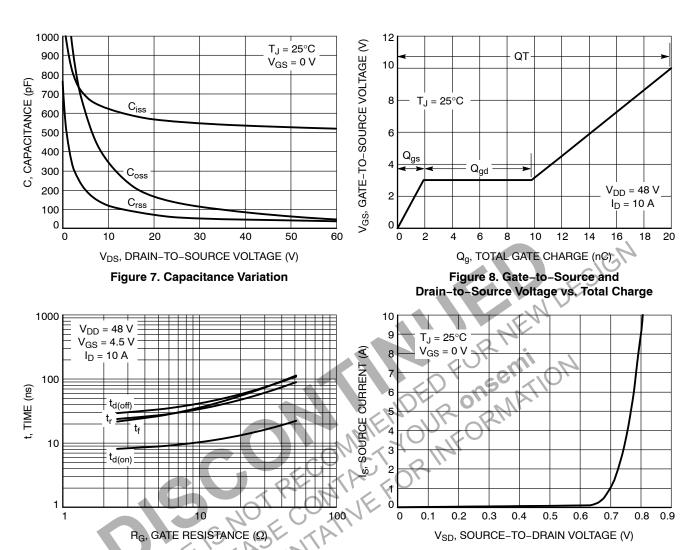


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

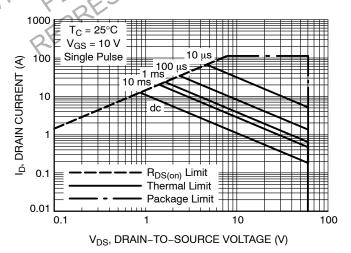
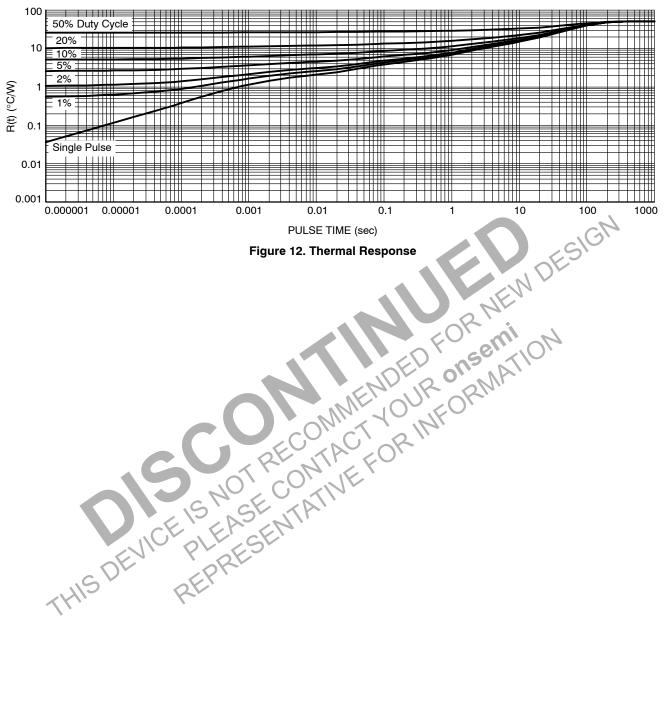


Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL CHARACTERISTICS





D

D1

TOP VIEW

SIDE VIEW

SCALE 2:1

PIN ONE IDENTIFIER

0.10 C

C 0.10

NOTE 7

NOTE 4

DFN8 5x6, 1.27P Dual Flag (SO8FL-Dual)

0.20 C

В

E1 E

SEATING PLANE

C

0.20 C

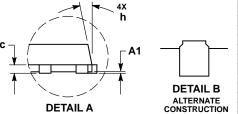
A

CASE 506BT ISSUE F

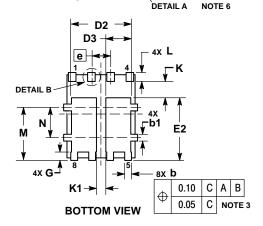
DATE 23 NOV 2021



- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION 6 APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 MM FROM THE TERMINAL TIP.
- PROFILE TOLERANCE APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
- DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH,
- PROTRUSIONS, OR GATE BURRS.
 SEATING PLANE IS DEFINED BY THE TERMINALS. A1 IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 7. A VISUAL INDICATOR FOR PIN 1 MUST BE LOCATED IN THIS AREA.



	MILLIMETERS				
DIM	MIN	MAX			
Α	0.90	-	1.10		
A1			0.05		
b	0.33	0.42	0.51		
b1	0.33	0.42	0.51		
С	0.20		0.33		
D		5.15 BSC			
D1	4.70	4.90	5.10		
D2	3.90	4.10	4.30		
D3	1.50	1.70	1.90		
E		6.15 BSC			
E1	5.70	5.90	6.10		
E2	3.90	4.15	4.40		
е	1.27 BSC				
G	0.45	0.55	0.65		
h		-	12 °		
K	0.51	-			
K1	0.56				
L	0.48	0.61	0.71		
М	3.25	3.50	3.75		
N	1.80	2.00	2.20		



GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week = Lot Traceability ZZ

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

SOLDERING FOOTPRINT* 4.56 2.08 8X 0.56 0.75 4X 6.59 4.84 1.40 2.30 3.70 0.70 4X 1.00 1.27 **PITCH** 5.55 **DIMENSION: MILLIMETERS**

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DFN8 5X6, 1.27P DUAL FLAG (SO8FL-DUAL)		PAGE 1 OF 1

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